

Notice of References Cited	Application/Control No. 10/764,670	Applicant(s)/Patent Under Reexamination SIMON, JEAN-YVES	
	Examiner Fritz Alphonse	Art Unit 2133	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,683,817	01-2004	Wei et al.	365/230.03
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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